

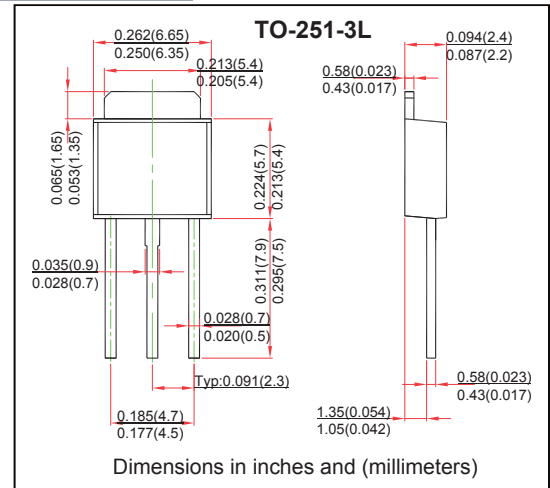
TO-251-3L Plastic-Encapsulate MOSFETS

FEATURE

- Robust High Voltage Termination
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete
- Fast Recovery Diode Diode is Characterized for Use in Bridge Circuits
- IDSS and VDS(on) Specified at Elevated Temperature
- N-Channel Power MOSFET

MECHANICAL DATA

- Case style: TO-251-3L molded plastic
- Mounting position: any



MAXIMUM RATINGS AND CHARACTERISTICS

@ 25°C Ambient Temperature (unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	600	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current	I_D	2	A
Pulsed Drain Current	I_{DM}	8	
Single Pulsed Avalanche Energy*	E_{AS}	128	mJ
Power Dissipation	P_D	1.25	W
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	100	°C/W
Junction Temperature	T_J	150	°C
Storage Temperature	T_{stg}	-50 ~+150	

* E_{AS} condition: $T_J=25^\circ\text{C}$, $V_{DD}=50\text{V}$, $L=64\text{mH}$, $I_{AS}=2\text{A}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$

MOSFET ELECTRICAL CHARACTERISTICS $T_A=25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Off characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{V}$, $I_D=250\mu\text{A}$	600			V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600\text{V}$, $V_{GS}=0\text{V}$			25	μA
		$V_{DS}=480\text{V}$, $V_{GS}=0\text{V}$, $T_J=125^\circ\text{C}$			100	
Gate-body leakage current	I_{GSS}	$V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$			± 100	nA
On characteristics (note 1)						
Gate-threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	2.0		4.0	V
Static drain-source on-resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}$, $I_D=1\text{A}$		3.6	4.4	Ω
Forward transconductance	g_{fs}	$V_{DS}=50\text{V}$, $I_D=1\text{A}$	1			S
Dynamic characteristics (note 2)						
Input capacitance	C_{iss}	$V_{DS}=25\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$		435		pF
Output capacitance	C_{oss}			56		
Reverse transfer capacitance	C_{rss}			9.2		
Switching characteristics (note 2)						
Total gate charge	Q_g	$V_{DS}=480\text{V}$, $V_{GS}=10\text{V}$, $I_D=2.4\text{A}$		40	50	nC
Gate-source charge	Q_{gs}			4.2		
Gate-drain charge	Q_{gd}			8.4		
Turn-on delay time	$t_{d(on)}$	$V_{DD}=300\text{V}$, $I_D=2\text{A}$, $V_{GS}=10\text{V}$, $R_G=18\Omega$		12		ns
Turn-on rise time	t_r			21		
Turn-off delay time	$t_{d(off)}$			30		
Turn-off fall time	t_f			24		
Drain-Source Diode Characteristics						
Drain-source diode forward voltage(note 1)	V_{SD}	$V_{GS}=0\text{V}$, $I_S=2\text{A}$			1.6	V
Continuous drain-source diode forward current	I_S				2	A
Pulsed drain-source diode forward current	I_{SM}				8	A

Notes:

1. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
2. Guaranteed by design, not subject to production.

Typical Characteristics

